IGBT Modules

IGBT Module(X series) 650V / 50A / IPM

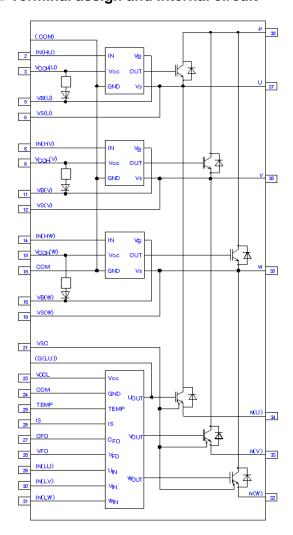
■ Features

Low-side IGBTs are separate emitter type Short circuit protection Temperature sensor output function Overheating protection Under voltage protection Fault signal output function Input interface:TTL(3.3V/5V)Active high logic

■Applications

AC 100~240V three phase inverter drive for small power AC motor drives(such as compressor motor drive for air conditioner, compressor motor drive for heat pump applications, ventilator motor drive)

■ Terminal assign and Internal circuit



■ Typical appearance



Pin No.	Pin Name	Pin Description	
2	IN(HU)	Signal input for high side U-phase	
3	VCCH(U)	Control supply for high side U-phase	
5	VB(U)	High-side bias voltage for	
	6,000,000	U-phase IGBT driving	
6	VS(U)	High-side U-phase drive supply GND	
8	IN(HV)	Signal input for high side V-phase	
9	VCCH(V)	Control supply for high side V-phase	
11	VB(V)	High-side bias voltage for	
	0.000.000.00	V-phase IGBT driving	
12	VS(V)	High-side V-phase drive supply GND	
14	IN(HW)	Signal input for high side W-phase	
15	VCCH(W)	Control supply for high side W-phase	
16	COM	Common supply ground	
18	VB(W)	High-side bias voltage for	
	0.0000000000	W-phase IGBT driving	
19	VS(W)	High-side W-phase drive supply GND	
21	VSC	Sense current detecting for low side	
23	VCCL	Low-side control supply	
24	COM	Common supply ground	
25	TEMP	Temperature sensor output	
26	IS	Over current sensing voltage input	
27	CFO	Capacitor for fault output width selection	
28	VFO	Fault output	
29	IN(LU)	Signal input for low side U-phase	
30	IN(LV)	Signal input for low side V-phase	
31	IN(LW)	Signal input for low side W-phase	
32	N(W)	Negative bus voltage input for W-phase	
33	N(V)	Negative bus voltage input for V-phase	
34	N(U)	Negative bus voltage input for U-phase	
35	W	Motor W-phase output	
36	V	Motor V-phase output	
37	Ü	Motor U-phase output	
38	P	Positive bus voltage input	

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■ Absolute Maximum Ratings(T_{vj} =25°C, T_{c} =25°C, V_{CC} =15V, $V_{B(^{\circ})}$ =15V unless otherwise specified)

	Items	Symbol	Characteristics	Unit	Remarks
	DC Bus Voltage	V _{DC} (terminal)	450	V	Note *1, See Fig.2-2
	Bus Voltage (Surge)	V _{DC(Surge,terminal)}	500	V	Note *1, See Fig.2-2
	Collector-Emitter Voltage	V _{CE(chip)}	650	V	Note *1, See Fig.2-2
	Collector Current	I _C	50	Α	Note *2
	Peak Collector Current	I _{CP}	100	А	V _{CC} ≥ 15V, V _{B(*)} ≥ 15V Note *2, *3, *4
<u>P</u>	Forward current	I _F	50	Α	Note *2
Inverter block	Peak Forward current	I _{FP}	100	Α	Note *2
b b	Collector Power Dissipation	P D_IGBT	132	W	per single IGBT T _c =25°C
읒	FWD power Dissipation	P _{D_FWD}	89	W	per single FWD T _c =25°C
	Self operation "DC Bus voltage" of circuit protection between upper-arm and lower- arm	V _{DC(sc)}	400	V	$V_{\text{CC}}=V_{\text{B(*)}}=13.5\sim16.5\text{V}$ $T_{\text{vj}}=125^{\circ}\text{C}$, non-repetitive less than 3us See Fig.2-2
	Virtual Junction Temperature	T _{vj}	175	°C	
	Operating Virtual Junction Temperature	$T_{ m vjop}$	-40 ~ +150	°C	Note *8
	High-side Supply Voltage	V _{CCH(U)} V _{CCH(V)} V _{CCH(W)}	-0.5 ~ 20	٧	Applied between VCCH(U)- COM, VCCH(V)-COM, VCCH(W)-COM
	Low-side Supply Voltage	V _{CCL}	-0.5 ~ 20	V	Applied between VCCL-COM
	High-side Bias Absolute Voltage	V _{VB(U)} -com V _{VB(V)} -com V _{VB(W)} -com	-0.5 ~ 670	٧	Applied between VB(U)-COM, VB(V)-COM
	High-side Bias Voltage for IGBT gate driving	V _{B(U)} V _{B(V)} V _{B(W)}	-0.5 ~ 20	V	Note *4
င္ပ	High-side Bias offset Voltage	V _U V _V V _W	-5 ~ 650	٧	Applied between U-COM, V-COM, W-COM Note *5
Control circuit bloc	Input Signal Voltage	V _{IN}	-0.5 ~ V _{CCH} +0.5 -0.5 ~ V _{CCL} +0.5	V	Note *6
cuit	Input Signal Current	I _{IN}	3	mA	sink current
blog	Fault Signal Voltage	V FO	-0.5 ~ V _{CCL} +0.5	V	Applied between VFO-COM
웃	Fault Signal Current	I _{FO}	1	mA	sink current
	CFO Signal Voltage	V _{CFO}	-0.5 ~ 5.0	V	Between CFO-COM Note *9
	CFO Signal Current	<i>I</i> CFO	-0.05 / 3	mA	source / sink current
	Over Current sensing Input Voltage	V _{IS}	-0.5 ~ V _{CCL} +0.5	V	Applied between IS-COM
	TEMP Signal Voltage	V _{TEMP}	-0.5 ~ 5.0	V	Between TEMP-COM Note *9
	TEMP Signal Current	I _{TEMP}	-0.05 / 3	mA	source / sink current
	VSC Signal Voltage	V _{VSC}	-0.5 ~ V _{CCL} +0.5	V	Between VSC-COM Note *9
	VSC Signal Current	lvsc	-20	mA	Source current
	Virtual Junction Temperature	T _{vj}	150	°C	
Ор	erating Case Temperature	T _c	-40 ~ +125	°C	See Fig.1-2
Sto	orage Temperature	T _{stg}	-40 ~ +125	°C	
Isc	olation Voltage	V _{isol}	AC 2500	Vrms	Sine wave,60Hz t=1min , Note *7



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Note

- *1: V_{DC} is applied between P-N(U),P-N(V),P-N(W). V_{CE} is Collector-Emitter voltage of internal IGBT chip.
- *2 : Pulse width and duty were limited by T_{vi} max.
- *3: V_{CC} is applied between VCCH-COM, VCCL-COM.
- *4: $V_{B(^*)}$ is applied between VB(U)-VS(U),VB(V)-VS(V), VB(W)-VS(W).
- *5: Over 13.0V applied between VB(U)-VS(U), VB(V)-VS(V), VB(W)-VS(W). This IPM module might make incorrect response if the high-side bias offset voltage is less than -5V.
- *6: Applied between IN(HU)-COM,IN(HV)-COM,IN(HW)-COM,IN(LU)-COM,IN(LV)-COM,IN(LW)-COM.
- *7: Applied between shorted all terminal and IMS (Insulated Metal Substrate).
- *8: The maximum temperature during continuous operation is T_{vj}=150°C. The operating conditions have to be decided so that the temperature is below T_{vj}=150°C. Continuous operation at over T_{vj}=150°C may result in degradation of product lifetime such as power cycling capability.
- *9: CFO, TEMP, VSC are output terminals. Never applied power source.

Electrical Characteristics

Inverter block

 $(T_{v_j}=25^{\circ}\text{C}, T_c=25^{\circ}\text{C}, V_{CC}=15\text{V}, V_{B(*)}=15\text{V}, V_{IN}=0\text{V}, V_{IS}=0\text{V}, V_{N(*)}=0\text{V} \text{ unless otherwise specified})$

Description	Symbol	Condi	Conditions		typ.	max.	Unit
Zero gate Voltage Collector current	,	V _{CE} = 650V	<i>T</i> _{vj} =25°C	-	-	1	mA
	I _{CE}		<i>T</i> _{vj} =125°C	-	-	10	mA
Collector-Emitter		/ - E0A	<i>T</i> _{vj} =25°C	-	1.30	1.65	
saturation Voltage	V _{CE(sat)} (terminal)		<i>T</i> _{vj} =125°C	-	1.45	1.80	V
Forward voltage	W	/ -504	T _{vj} =25°C	-	1.55	2.05	V
_	V_{F}	/ _F	<i>T</i> _{vj} =125°C	-	1.60	-	V
Turn-on time	t _{on}			1.20	1.70	2.50	
Turn-on delay time	t _{d(on)}			-	1.60	-	
Turn-on rise time	t _r			-	0.15	-	
V _{CE} -I _C Cross time of turn-on	t _{c(on)}	$V_{DC} = 300V$ $I_{C} = 50A$		-	0.35	0.70	
Turn-off time	t _{off}	T _{vj} = 125°C		-	1.85	2.50	μS
Turn-off delay time	$t_{ m d(off)}$	V _{IN} =0V <-> 5∖ See Fig.2-1	′	-	1.75	-	μο
Turn-off fall time	t _f	Note *4		-	0.15	-	
V _{CE} -I _C Cross time of turn-off	$t_{\text{c(off)}}$			-	0.35	0.70	
Reverse Recovery time	t _{rr}			-	0.25	-	

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Control circuit block

 $(\textit{T}_{\textrm{vj}}\textrm{=}25^{\circ}\textrm{C},~\textit{T}_{\textrm{c}}\textrm{=}25^{\circ}\textrm{C},~\textit{V}_{\textrm{CC}}\textrm{=}15\textrm{V},~\textit{V}_{\textrm{B(*)}}\textrm{=}15\textrm{V},~\textit{V}_{\textrm{IN}}\textrm{=}0\textrm{V},~\textit{V}_{\textrm{IS}}\textrm{=}0\textrm{V},~\textit{V}_{\textrm{N(*)}}\textrm{-}\textrm{COM}}\textrm{=}0\textrm{V}~\textrm{unless otherwise specified})$

Description	Symbol	Cond	litions	min.	typ.	max.	Unit
Circuit current of	1	V _{CCL} =15V	V _{IN} =5V	-	0.7	1.1	mΛ
Low-side	I _{CCL}	VCCL-13V	V _{IN} =0V	-	0.7	1.1	mA
Circuit current of		V _{CCH(U)} =15V,	V _{IN} =5V	-	1.2	1.9	
High-side (per one unit)	I _{CCH}	V _{CCH(V)} =15V, V _{CCH(W)} =15V	V _{IN} =0V	-	1.2	1.9	mA
Circuit current of		V _{B(U)} =15V,	V _{IN} =5V	-	-	0.20	
Bootstrap circuit (per one unit)	І сснв	V _{B(V)} =15V, V _{B(W)} =15V	V _{IN} =0V	-	-	0.20	mA
Input Signal threshold	$V_{th(on)}$			1.6	2.1	2.6	V
voltage	$V_{ m th(off)}$	Note *10		0.8	1.3	1.8	V
Input Signal threshold hysteresis voltage	V _{th(hys)}	<i>PW</i> ⊵1.5μs		0.35	0.8	-	V
Operational input pulse width of turn-on	t _{IN(on)}	V _{IN} =0V to 5V r Note *6,Note *		1.5	-	-	μS
Operational input pulse width of turn-off	t _{IN(off)}	V _{IN} =5V to 0V f Note *6,Note *		0.8	-	-	μS
Input current	I _{IN}	V _{IN} =5V Note *6		0.7	1.0	1.5	mA
Input pull-down resistance	R _{IN}	Note *6		3.3	5.0	7.2	kΩ
Fault Output Voltage	V _{FO(H)}	$V_{\rm IS}$ =0V, $V_{\rm FO}$ terminal pull up to 5V by 10k Ω		4.9	-	-	V
	V _{FO(L)}	V _{IS} =1V, I _{FO} =1m	A	-	-	0.95	V
Fault Output pulse width	t _{FO}	C _{FO} =22nF Note *12,See Fig2-3,2-4		1.6	2.4	-	ms
Over Current Protection Voltage Level	V _{IS(ref)}	V _{CC} =15V Note *3, *11, *	12	0.455	0.48	0.505	V
Over Current Protection Delay time	t _{d (IS)}	See Fig.2-3		0.6	1.25	1.9	μs
Over current trip level	I _{oc}	Rsc =40.2Ω(\pm 1%), No shunt resistor connecting to N(U),N(V),N(W) See Fig.1-1		85	-	-	Α
Output Voltage of	V _(temp)	Note *13	T _{vj(LVIC)} =90°C	2.63	2.77	2.91	V
temperature sensor	(remp)		T _{vj(LVIC)} =25°C	0.88	1.13	1.39	V
Pull down Resistance of TEMP terminal	R _(temp)	Note *14		5	-	-	kΩ
LVIC Overheating protection	Тон	Note *11, *12, *13		136	143	150	°C
T _{OH} Hysteresis	$T_{ m OH(hys)}$	See Fig.2-7	_	4	10	20	°C

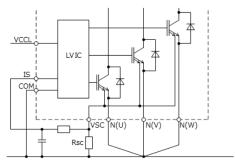
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Control circuit block (continued)

 $(T_{v_i}$ =25°C, T_c =25°C, V_{cc} =15V, $V_{B(*)}$ =15V, V_{IN} =0V, V_{IS} =0V, $V_{N(*)}$ _{COM}=0V unless otherwise specified)

Description	Symbol	Conditions	min.	typ.	max.	Unit
V _{CC} Under Voltage Trip Level of Low-side	V _{CCL(OFF)}		10.3	-	12.5	V
V _{CC} Under Voltage Reset Level of Low-side	V _{CCL(ON)}	<i>T</i> _{vj} <150°C See Fig.2-4 Note *12	10.8	-	13.0	V
V _{CC} Under Voltage hysteresis	V _{CCL(hys)}	, <u>-</u>	-	0.5	-	V
V _{CC} Under Voltage Trip Level of High-side	V _{CCH(OFF)}		8.3	-	10.3	V
V _{CC} Under Voltage Reset Level of High-side	V _{CCH(ON)}	T _{vj} <150°C See Fig.2-5	8.8	-	10.8	V
V _{CC} Under Voltage hysteresis	V _{CCH(hys)}		-	0.5	-	V
V _B Under Voltage Trip Level	V _{B(OFF)}		10.0	-	12.0	V
V _B Under Voltage Reset Level	V _{B(ON)}	T _{vj} <150°C See Fig.2-6	10.5	-	12.5	V
V _B Under Voltage hysteresis	V _{B(hys)}		-	0.5	-	V
Forward voltage of Bootstrap diode	V _{F(BSD)}	T _{vj} =25°C I _{F(BSD)} =10mA	0.5	0.9	1.3	V
Built-in limiting resistance	R _(BSD)	<i>T</i> _{vj} =25°C	16	20	24	Ω

Fig.1-1: Over current protection circuit



Note

- *10 : This IPM module might make incorrect response if the input signal pulse width is less than $t_{\rm IN(on)}$ and $t_{\rm IN(off)}$.
- *11: "Over current protection" is functioning only for the low-side arms.
- *12 : Fault signal is asserted corresponding to an "Over-current protection" or an "Under-voltage protection" at $V_{\rm CCL}$.
 - Under the condition of "Over-current protection" or "Under-voltage protection", the fault signal is asserted continuously while these conditions are continuing.
 - However, the minimum fault output pulse width is $t_{FO}(\text{min.})$ even if very short failure condition (which is less than $t_{FO}(\text{min.})$) is triggered. The fault output pulse-width t_{FO} depends on the capacitance value of C_{FO} . ($C_{FO}(\text{typ.}) = t_{FO} \times (9.1 \times 10^{-6})$ [F])
- *13: Fig.1-2 shows the measurement position of temperature.
- *14: It is recommended to insert pull down resister for getting linear output characteristics at low temperature below room temperature.

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Thermal Characteristics ($T_c=25^{\circ}C$)

Description	Symbol	min.	typ.	max.	Unit
Junction to Case Thermal Resistance (per single IGBT) Note *15	R _{th(j-c)_} IGBT	-	-	0.95	°C/W
Junction to Case Thermal Resistance (per single Diode) Note *15	R _{th(j-c)_} FWD	-	-	1.40	°C/W

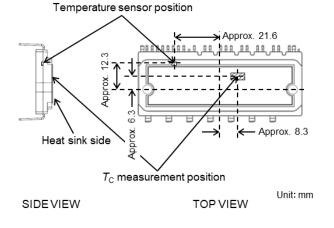
Note

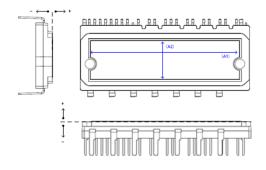
Mechanical Characteristics (T_c=25°C)

Description	Symbol	Conditions	min.	typ.	max.	Unit
Mounting torque of screws	M _S	Mounting screw: M4	0.98	1.18	1.47	Nm
Heat-sink side flatness	-	The AL-IMS part : See (A1),(A2) of Fig.1-3.	-50	-	100	μm
Weight	-	-	-	37	-	g
Resistance to soldering heat	-	Solder temp:260±5°C Immersion time:10±1sec Solder alloy:Sn-Ag-Cu type	-	-	1	time

Fig.1-2: The measurement position of temperature

Fig.1-3:
The measurement position of heat sink flatness





Note

*16 : Fig.1-3 shows the measurement position of heat sink flatness.

^{*15 :} Thermal compound with good thermal conductivity should be applied evenly with about +100μm~+200μm on the contacting surface of this device and heat-sink.

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Recommended Operation Conditions (Note*20)

Description	Symbol	min.	typ.	max.	Unit
DC Bus Voltage	V _{DC}	0	300	400	V
High-side Bias Voltage for IGBT gate driving	<i>V</i> _{B(*)}	13.0	15.0	18.5	V
High-side Supply Voltage	V _{CCH(*)}	13.5	15.0	16.5	V
Low-side Supply Voltage	V _{CCL}	13.5	15.0	16.5	V
Control Supply variation	△V _B	-1	-	1	\//a
(Under switching Condition)	△Vcc	-1	-	1	· V/μs
Input signal voltage	V _{IN}	0	-	5	V
Voltage for current sensing	V _{ISC}	0	-	5	V
Potential difference between COM and N (including surge)	V _{COM_N}	-5	-	5	V
Dead time for preventing arm-short (<i>T</i> _c ≤125°C)	t _{DEAD}	2.2	-	-	μS
Output current (Note *17)	10	-	-	50	A rms
Minimum input pulse width	PW _{IN(on)}	1.5	-	-	μS
(Note *18, *19)	PW _{IN(off)}	0.8	-	-	μS
PWM Input frequency	f _{PWM}	-	-	20	kHz
Operating Virtual Junction Temperature	T _{vjop}	-30	-	150	°C
Capacitance value between CFO and COM (Note*21)	C _{FO}	1	22	-	nF

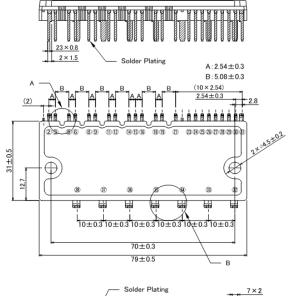
Note

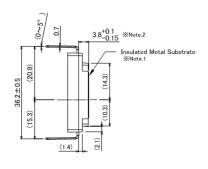
- *17 : $V_{\rm DC}$ =300V, $V_{\rm CCH(^*)}$ = $V_{\rm CCL}$ = $V_{\rm B(^*)}$ =15V, PF=0.8, Sinusoidal PWM, 3phase modulation, $T_{\rm Vj}$ ≤150°C , $T_{\rm C}$ ≤100°C , $T_{\rm PWM}$ =5kHz, $T_{\rm C}$ =200Hz, Ks=0.9
- *18: In the pulse width of 1.5us, the loss of IGBT increases for the saturation operation.

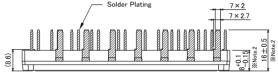
 To reduce the loss of IGBT, please enlarge the pulse width more than the switching time of IGBT.
- *19: This IPM module might response according to input signal pulse even when the input signal pulse width is less than $PW_{IN(on)}$ and $PW_{IN(off)}$.
- *20: Recommended operating conditions are conditions for guaranteeing that the product operates normally. If it is used beyond this condition, operation and reliability may be adversely affected.
- *21: It is recommended to use low leakage current ceramic capacitor such as Murata Manufacturing RCER 71H series.

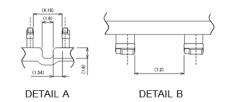
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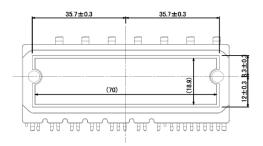
Package Outline dimensions ($T_c=25$ °C)











Pin	Pin	Pin	Pin	Pin	Pin
No.	Name	No.	Name	No.	Name
2	IN(HU)	21	VSC	32	N(W)
3	VCCH(U)	23	VCCL	33	N(V)
5	VB(U)	24	COM	34	N(U)
6	VS(U)	25	TEMP	35	W
8	IN(HV)	26	IS	36	V
9	VCCH(V)	27	CF0	37	U
11	VB(V)	28	VFO	38	Р
12	VS(V)	29	IN(LU)		
14	IN(HW)	30	IN(LV)		
15	VCCH(W)	31	IN(LW)		
16	COM			_	
18	VB(W)	_		/	
19	VS(W)			\vee	

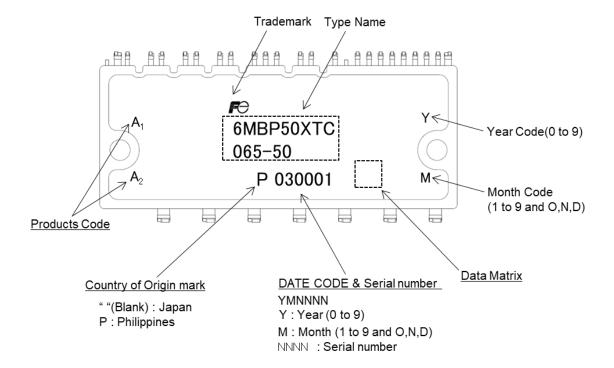
Unit:mm

Note.1 The IMS (Insulated Metal Substrate) is deliberately protruded to improve the thermal conductivity

Note.2 Thickness from the package surface to the back side including the IMS.

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Marking



Note

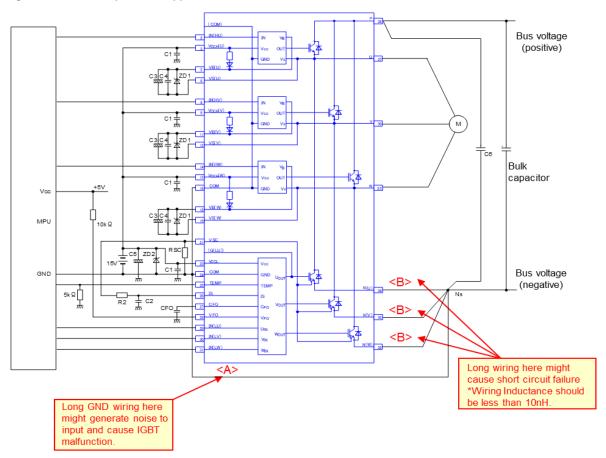
Product code A₁ means current ratings, and "A" is marked.

Product code A₂ means variations, and "A" is marked.

IGBT Modules

An example of application circuit.

Fig. shows an example of an application circuit.



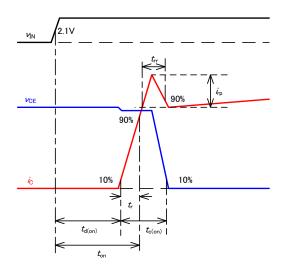
<Note>

- Input signal for drive is High-Active. There is a pull-down resistor built in the IC input circuit. To prevent malfunction, the wiring of each
 input should be as short as possible. When using R-C coupling circuit, make sure the input signal level meet the turn-on and turn-off
 threshold voltage.
- By the function of the HVIC, it is possible of the direct coupling to microprocessor (MPU) without any photo-coupler or pulsetransformer isolation.
- 3. VFO output is open drain type. It should be pulled up to the positive side of a 5V power supply by a resistor of about 10kΩ.
- To prevent erroneous protection, the wiring of (A), (B) should be as short as possible.
- The time constant R2-C2 of the protection circuit should be selected approximately 1.1μs.
 Over current (OC) shutdown time might vary due to the wiring pattern. Tight tolerance, temp-compensated type is recommended for R2-C2
- All capacitors should be mounted as close to the terminals of the IPM as possible. (C1, C4: narrow temperature drift, higher frequency and DC bias characteristic ceramic type are recommended, and C3, C5: narrow temperature drift, higher frequency and electrolytic type.)
- To prevent surge destruction, the wiring between the snubber capacitor and the P terminal, Ns node should be as short as possible.
 Generally a 0.1 μ to 0.22 μF snubber capacitor (C6) between the P terminal and Ns node is recommended.
- 8. Two COM terminals (16 & 24 pin) are not connected inside the IPM, it must be both connected to the signal GND outside.
- 9. It is recommended to insert a zener-diode (22V) between each pair of control supply terminals to prevent surge destruction.
- If signal GND is connected to power GND by broad pattern, it may cause malfunction by power GND fluctuation. It is recommended to connect signal GND and power GND at only a point.
- 11. For sense resistor: R_{SC}, It should be pull down with 24 Ω or more to COM terminal, and the variation within 1% (including temperature characteristics), low inductance type is recommended. And the over 1/8W recommended, but it is necessary to evaluate in your real system finally.
- Error signal output width(t_{FO}) can be set by the capacitor between CFO terminal and COM terminal. C_{FO}(typ.) = t_{FO} x (9.1 x 10⁻⁶) (F)
- 13. When using an external shunt resistor for over current protection, use a chip-type shunt resistor with low inductance. Do not use a shunt resistor with a large inductance, such as a cement resistor.

IGBT Modules

Operation sequence

Fig.2-1 Switching waveforms



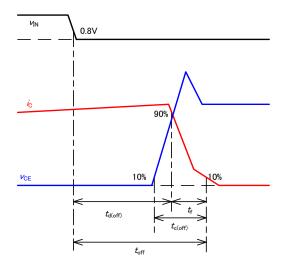
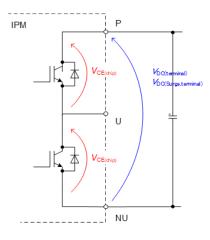
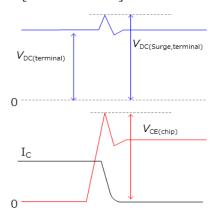


Fig.2-2 Rated Voltage

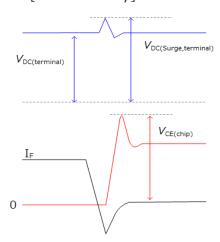


- \cdot $V_{\rm DC(terminal)},~V_{\rm DC(Surge,terminal)}$ are applied between P-N(U),P-N(V),P-N(W) at the lead stopper.
- $\cdot V_{\mathrm{CE(chip)}}$ is Collector-Emitter voltage of internal IGBT chip.

[IGBT turn-off]

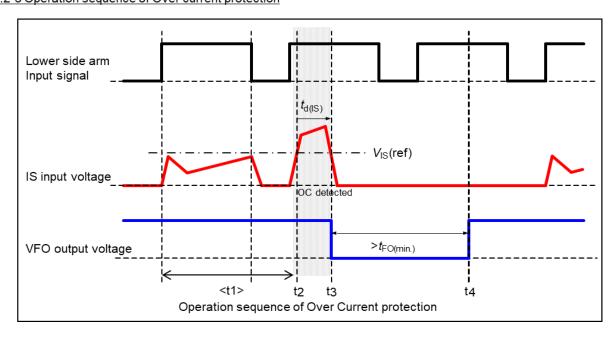


[FWD recovery]



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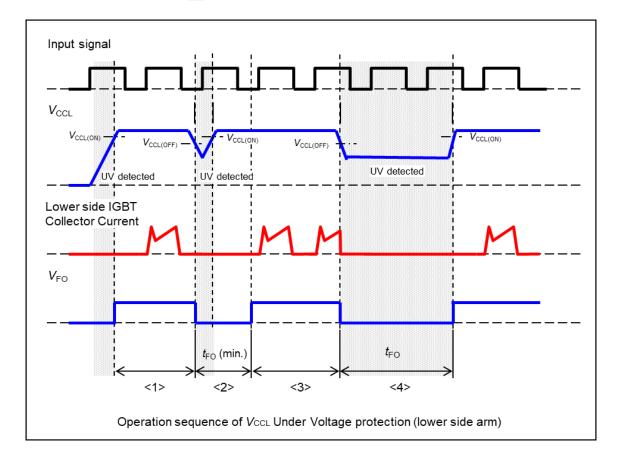
Fig.2-3 Operation sequence of Over current protection



- <t1> : IS input voltage does not exceed V_{IS(ref)}, while the collector current of the lower side IGBT is under the normal operation.
- t2 : When IS input voltage exceeds $V_{\rm IS(ref)}$, the OC is detected.
- t3 : The fault output VFO is activated and all lower side IGBT shut down simultaneously after the over current protection delay time $t_{\rm d(IS)}$. Inherently there is dead time of LVIC in $t_{\rm d(IS)}$.
- t4 : After the fault output pulse width $t_{\rm FO}$, the OC is reset. Then next input signal is activated.

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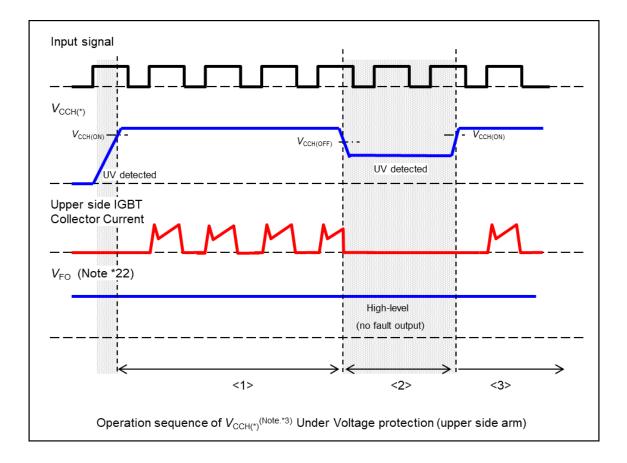
Fig.2-4 Operation sequence of V_{CCL} Under voltage protection (lower side arm)



When VCCL is under 4V, UV and fault output are not activated.

- <1> When $V_{\rm CCL}$ is under $V_{\rm CCL(ON)}$, all lower side IGBTs are OFF state. After $V_{\rm CCL}$ rises $V_{\rm CCL(ON)}$, the fault output VFO is released (high level). And the LVIC starts to operate, then next input is activated.
- <2> The fault output VFO is activated when $V_{\rm CCL}$ falls below $V_{\rm CCL(OFF)}$, and all lower side IGBT remains OFF state.
 - When the voltage drop time is less than $t_{FO}(min.)$, the fault output pulse width is generated $t_{FO}(min.)$ and all lower side IGBTs are OFF state in spite of input signal condition during that time.
- <3> UV is reset after t_{FO} when V_{CCL} exceeds $V_{\text{CCL(ON)}}$ and the fault output VFO is reset simultaneously.
 - And the LVIC starts to operate, then next input is activated.
- <4> When the voltage drop time is more than too, the fault output pulse width is generated and all lower side IGBTs are OFF state in spite of input signal condition during the same time.

Fig.2-5 Operation sequence of V_{CCH(*)} Under voltage protection (upper side arm)

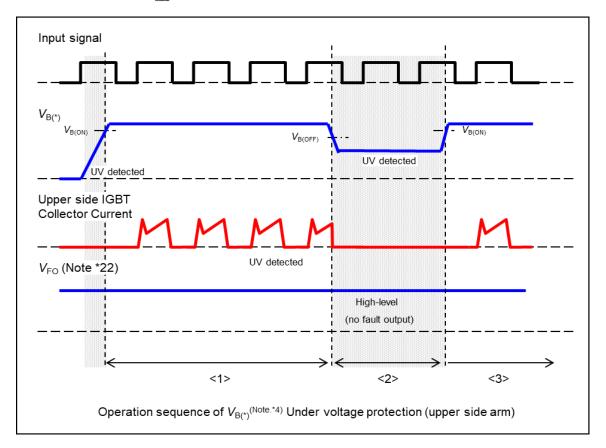


- <1> When Vcch(U), Vcch(V) or Vcch(W) are under Vcch(ON), the corresponding upper side IGBTs are OFF state. After Vcch(U), Vcch(V) or Vcch(W) exceed Vcch(ON), the corresponding upper side IGBTs start to operate. Then next input is activated.
 The fault output VFO is constant (high level) not to depend on Vcch(*). (Note*22)
- <2> After Vcch(U), Vcch(V) or Vcch(W) fall below Vcch(OFF), the corresponding upper side IGBTs remain OFF state. But the fault output VFO keeps high level.
- <3> The HVIC starts to operate after UV is reset, then next input is activated.

Note *22 : The fault output is not given HVIC bias conditions.

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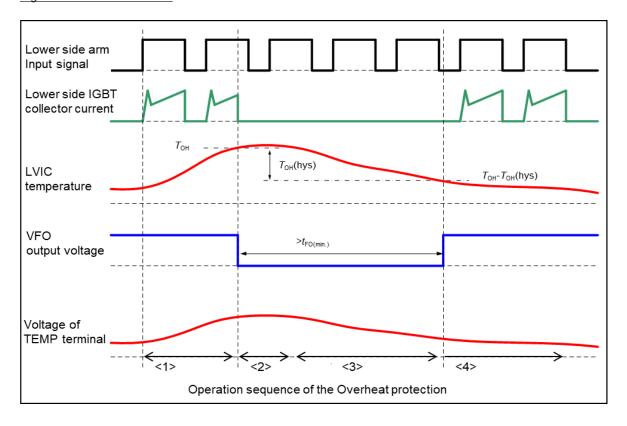
Fig. 2-6 Operation sequence of V_{B(*)} Under voltage protection (upper side arm)



- <1> When $V_{B(U)}$, $V_{B(V)}$ or $V_{B(W)}$ are under $V_{B(ON)}$, the corresponding upper side IGBTs are OFF state. After $V_{B(U)}$, $V_{B(V)}$ or $V_{B(W)}$ exceed $V_{B(ON)}$, the corresponding upper side IGBTs start to operate. Then next input is activated. The fault output VFO is constant (high level) not to depend on $V_{B(^*)}$. (Note*22)
- <2> After $V_{B(U)}$, $V_{B(V)}$ or $V_{B(W)}$ fall below $V_{B(OFF)}$, the corresponding upper side IGBTs remain OFF state. But the fault output VFO keeps high level.
- <3> The HVIC starts to operate after UV is reset, then next input is activated.

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Fig.2-7 Overheat Protection



This function is applied to "6MBP**XTC065-50".

The IPM has Overheat protection (OH) function by monitoring the LVIC temperature.

The T_{OH} sensor position is shown in Fig.1-2 (P6).

- <1> The collector current of the lower side IGBT is under the normal operation while the LVIC temperature does not exceed $T_{\rm OH}$.
- <2> The IPM shutdown all lower side IGBTs while the LVIC temperature exceeds T_{OH} .
- <3> The TEMP terminal continue to output the voltage which correspond to temperature of LVIC even if IPM is in OH condition.
- <4> The fault status is reset when the LVIC temperature drops below ($T_{\rm OH}$ - $T_{\rm OH(hys.)}$). All lower side IGBTs restart to normal operation.



Technical Information

IGBT Modules

- Please refer to URLs below for futher information about products, application manuals and design support.
- ●关于本规格书中没有记载的产品信息,应用手册,技术信息等,请参考以下链接。
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